

ACOUSTICAL

SENSITIVITY DEVICE WILL PRODUCE THE SPL LISTED BELOW WITH THE TEST CONDITIONS DESCRIBED IN TABLE 3. NOMINAL SENSITIVITY AT 1 kHz IS dB RELATIVE TO 20µPa. ALL OTHER VALUES IN

db relative to the SenStitvity at 1 kHz.							
LIMIT TYPE	FREQUENCY (Hz)	MINIMUM	NOMINAL	MAXIMUM			
REL	20	+3.5	+7.5	+11.5			
REL	100	+3.0	+7.0	+ . 0			
REL	200	+2.0	+5.0	+8.0			
REL	500	-0.5	+2.0	+3.5			
REF	1000	-2.0	106.2	+2.0			
PEAK	2850-3450	+6.5	+9.5	+12.5			
VALLEY	6400-8000	-15.0					
PEAK	8000-11000	-12.0	-7.0	-2.0			

TABLE I.

TOTAL HARMONIC DISTORTION DEVICE WILL NOT EXCEED TOTAL HARMONIC DISTORTION LEVELS LISTED BELOW.

FREQUENCY (Hz)	DRIVE (Vrms)	LIMIT (%)
50	0.115	5.8
1/3 PEAK I (TYP. 1050)	0.115	6.8
1/2 PEAK I (TYP. 1575)	0.115	4.8
1/3 PEAK I (TYP. 1050)	0.324	9.5
1/2 PEAK I (TYP. 1575)	0.324	9.5

TABLE 2.

TEST CONDITIONS

ILSI COMBINONS	·
NOMINAL SOURCE VOLTAGE	0.115 Vrms
SOURCE IMPEDANCE	< Ι Ω
TUBING	TUBELESS, DIRECT TO 711 COUPLER
COUPLER CAVITY	IEC 60318-4 (IEC 711)

TABLE 3.

ELECTRICAL

DC RESISTANCE	22.0 Ω ±10%
IMPEDANCE @ 500 Hz	33.0 Ω ±15%
IMPEDANCE @ kHz	50.0 Ω ±15%
INDUCTANCE @ 500 Hz	7.8 mH TYPICAL

TABLE 4.

ISOLATION: THE CASE WILL BE ELECTRICALLY ISOLATED FROM THE COIL CIRCUIT

ELECTRICAL-ACOUSTICAL

TYPICAL PERFORMANCE AT I kHz

SENSITIVITY TO 100 mV	105 dB
SENSITIVITY TO 1 mW	II2 dB
MAX. SPL (10% THD)	II7 dB
MAX. DRIVE VOLTAGE	1.0 V
THD AT 94 dB SPL	0.4%
THD AT 100 dB SPL	0.6%

TABLE 5.

MECHANICAL

PORT LOCATION: 12S

SOLDER TYPE: ROHS COMPLIANT

SAC305

TEMPERATURE

RECEIVER

PERFORMANCE SPECIFICATION

TITLE:

OPERATING: SENSITIVITY WILL NOT VARY MORE

THAN +1/-3 dB FROM 0°C TO 63°C

STORAGE: -40°C TO 63°C

	Revision	C.O. #	Implementation Date	RELEASE LEVEL		REVISION
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				l Active		Д
	А	C10116956	10-20-15	7101110		/ \
Ī	WHEN TEST I	IMITS ARE US	SED TO ESTABLISH INCOMING	INSPECTION ACCEPTANCE/REJECTION	DR. BY	DATE

SHT 2.1

KNOWLES ELECTRONICS ITASCA, ILLINOIS U.S.A.

WHEN TEST LIMITS ARE USED TO ESTABLISH INCOMING INSPECTION ACCEPTANCE/REJECTION PR. BY CRITERIA, CORRELATION OF TEST EQUIPMENT WITH KNOWLES IS ALSO REQUIRED FOR ELIMINATION OF EQUIPMENT AND TEST METHOD VARIATION

SSUN

IS ALSO REQUIRED FOR	SSUN ck. by	10-20-15 DATE
RAF-32873-000	GJP APP. BY	10-21-15 Date
SHT 2.1	GJP	10-21-15

APPLICATION NOTES:

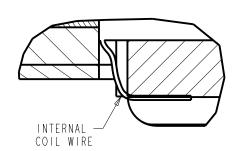
I. HANDLING AND ASSEMBLY:
LIMIT APPLIED FORCE TO LEVELS SHOWN IN FIGURE BELOW TO AVOID DAMAGE.
DAMPER SURFACE MUST BE KEPT CLEAN AND UNOBSTRUCTED DURING APPLICATION TO ACHIEVE SPECIFIED PERFORMANCE.

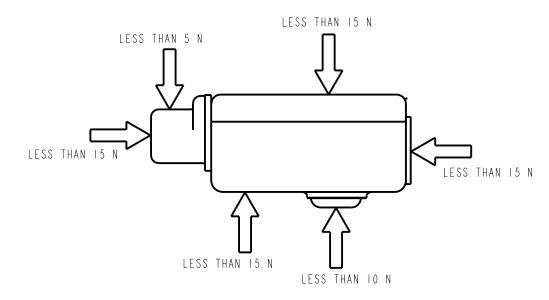
CHANGE TO AIR FLOW THROUGH DAMPING SCREW WILL CAUSE A RESPONSE CHANGE AT LOW FREQUENCIES. DO NOT ABRADE OR COVER MATERIAL IN FINAL APPLICATION.

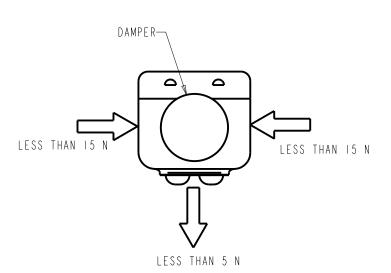
2. BACK VOLUME:

"BACK VOLUME" OF HOUSING/SHIELD AFTER ASSEMBLY SHOULD NOT BE LESS THAN 0.02 CC. TO ACHIEVE SPECIFIED RESPONSE, "BACK VOLUME" SMALLER THAN 0.02 CC MAY CAUSE A RESPONSE CHANGE AT LOW FREQUENCIES.

- 3. TERMINAL AND SOLDERING: THE INTERNAL COIL WIRE OF THE TRANSDUCER IS TERMINATED TO THE EXTERNAL SOLDER PADS, WHEN SOLDERING EXTERNAL WIRES TO SOLDER PAD, PLEASE TAKE CARE NOT TO DAMAGE THE EXISTING INTERNAL WIRE
- 4. SOLDER PAD PULL FORCE: SOLDER PADS ARE DESIGNED TO WITHSTAND 5 N OF PULL FORCE.
- 5. IN ORDER TO MINIMIZE DEVICE DAMAGE: DO NOT INSERT ANY OBJECT INTO THE PORT HOLE OF DEVICE. PREVENT ANY LIQUIDS FROM ENTERING INSIDE OF RECEIVER.
 TAKE CARE TO AVOID DROPPING UNPROTECTED RECEIVER ONTO HARD SURFACES, DROPPING UNPROTECTED RECEIVER ONTO HARD SURFACES MAY CAUSE INTERNAL DAMAGE, REDUCING PERFORMANCE.







RELIABILITY TEST

STANDARDS/ SPECIFICATIONS	TEST ITEM	TEST CONDITIONS	ACCEPTANCE CRITERIA Sensitivity change <3dB at 1000 Hz	
QAP-8040	HALT (Highly Accelerated Life Test)	63°C at 95% RH +9dB drive at resonance for 2 weeks		
IEC 68-2-38	Composite Temp & Humidity Cyclic Test	Test 2b (10 cycles of 24 hours each) 25°C / 80-100% RH for 3 h 65°C / 90-100% RH for 5 h -10°C / 0% RH for 5 h	Sensitivity change <3dB at 1000 Hz	
QAP-8100	Thermal Shock	5 cycles: -40°C to +63°C, 15 minute soaks, <30 sec. transition	Sensitivity change <3dB at 1000 Hz	
QAP-8640	Artificial Sweat Test	IO days exposure to sweat vapor at 38°C	Sensitivity change <3dB at 1000 Hz	
QAP-8070	Solder / De-Solder Cycle Test	Tip temp 750F (400°C): 5 cycles 2 seconds / pad	Sensitivity change < IdB at 1000 Hz	
QAP-8200	Mechanical Shock	Drop from progressively higher heights until failure. "Failure" means that sensitivity changes >3dB from initial, or THD at nominal drive at 1/3 resonance > 10%, or THD at nominal drive at 1/2 resonance > 20%.	>90% survival rate @ I4.I kG shock level.	
IEC 68-2-64	Vibration Stress (with Packaging Material)	10 Hz - 60 Hz w / const. amp of 3.5 mm 60 Hz - 150 Hz w / const. acc of 30 G sweep 10 oct / min, 10 min in each axis	Sensitivity change <1 dB at 1000 Hz	
QAP 9130	Powered Salt Fog	2 weeks exposure to 35°C salt fog chamber with salt deposition 20~50g/sq.m/24 hours. powered with AC 0.289 Vrms @ lkHz.	DCR test within spec (22.0 Ω ±10%).	

NOTE: QAP IS THE ABBREVIATION FOR QUALITY ASSURANCE PROCEDURES. THESE ARE KNOWLES INTERNAL DOCUMENTS TO CONTROL PRODUCT QUALITY.

Revision C.O. # Implementation Date RELEASE LEVEL			RELEASE LEVEL		REVISION	
A	C10116956	10-20-15		Active		Α
	HEN TEST ETHITS AND SOLD TO ESTABLISH THOOMING THOSECTION ACCELIANCE AND CONTROL		DR. BY	DATE		
CRITERIA, CORRELATION OF TEST EQUIPMENT WITH KNOWLES IS ALSO REQUIRED FOR ELIMINATION OF EQUIPMENT AND TEST METHOD VARIATION				SSUN	10-20-15	
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TITLE:	RF	CEIVER		RAF-32873-000	GJP	10-21-15
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	PERFORMAN	NCE SPECIFICA	TION	SHT 2.2	GJP	10-21-15